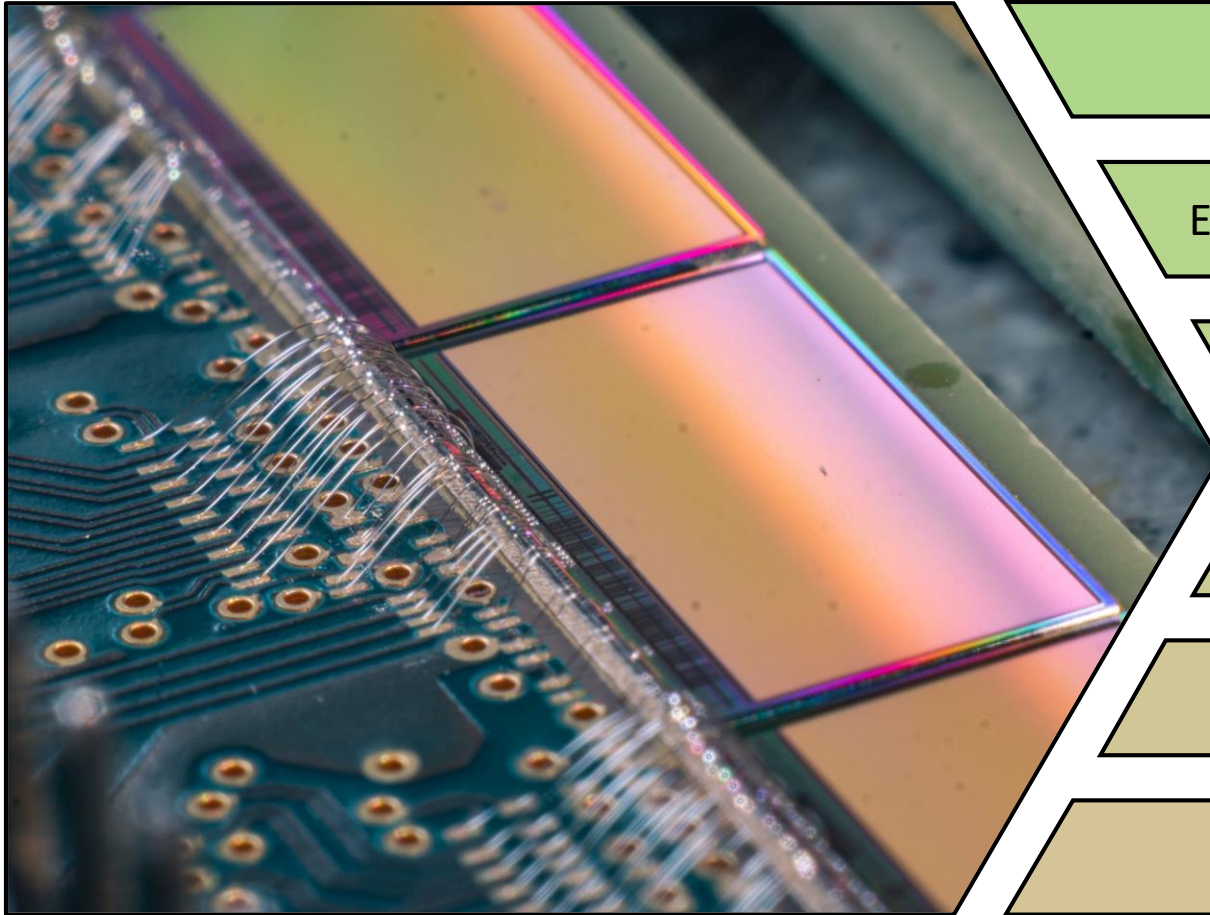


Monolithic CMOS pixel sensors for low energy X-rays

Elio Sacchetti
on behalf of C4Pi group

3 - 4 June 2024
LPSC - Grenoble



The C4Pi platform at IPHC

Evolution of CPS: how to detect low energy X-ray ?

A sensor for low energy X-ray detection :
“Monolithic Imager 1”

Developing a physics-electronics
integrated simulation based on MI-1

Technology transfer: “TIIMM” sensor

Conclusion

The C4Pi platform at IPHC

C4Pi platform: "Centre de Compétences de Capteurs CMOS à Pixels Intégrés"

~ 20 engineers + technicians

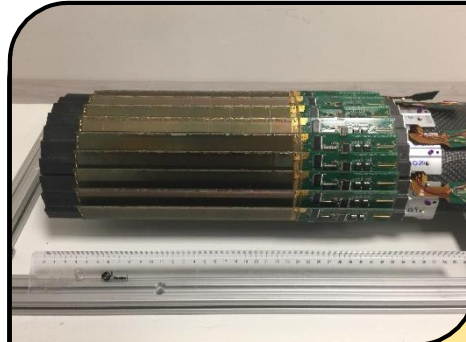
CMOS MAPS sensors development:

Specifications + Design + Validation + Tests + Integration



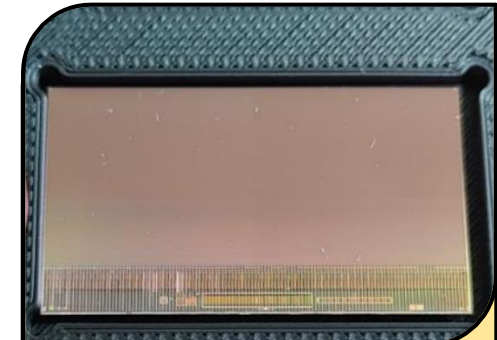
Sensor : MIMOSA 26
Beam telescope applications

2008



Sensor : MIMOSA 28
STAR exp. @BNL

2010

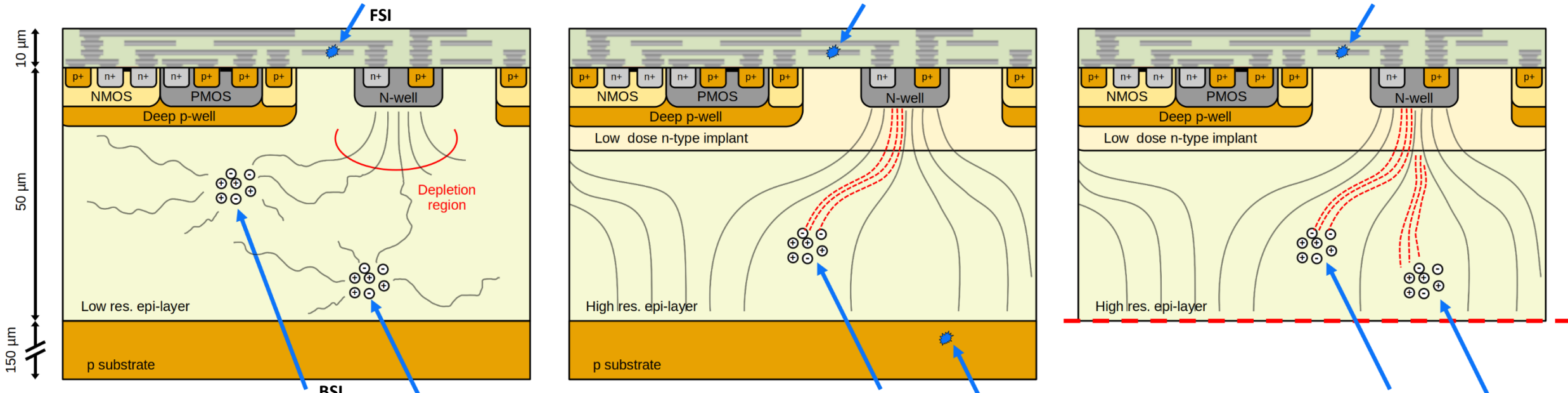


Sensor : MIMOSIS 1
CBM exp. @FAIR/GSI

2023

Features developed for particle physics projects => Transfer to spin-off applications

Evolution of CPS: how to detect low energy X-ray ?



Standard process - low res. epitaxial layer

Simple readout architecture (3T)

Small depletion volume

Charge collection mainly by diffusion

Modified process - high res. epitaxial layer + n-type implant

High res. : whole epi. layer depleted

N-type implant: depletion for low voltage

Better radiation tolerance

Thick substrate for low energy X-ray

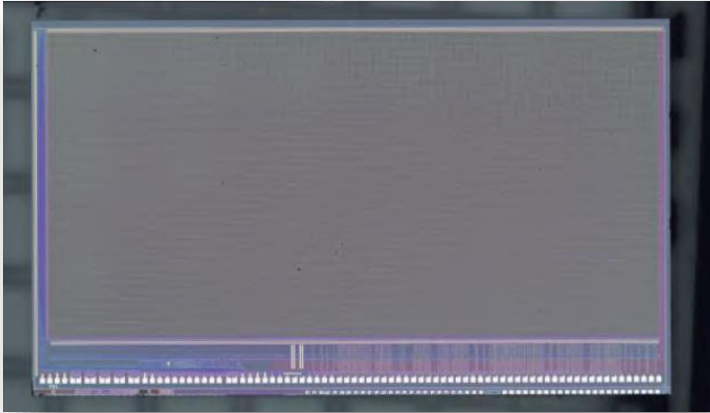
Modified process + backside processing

Thinning + ion implantation + laser annealing

Thin entrance window

W. Snoeys et al "A process modification for CMOS MAPS ..." NIM A, vol 871 (2017)

Specifications



[1 - 10] keV X-ray detection, designed for spectroscopic applications

Operation mode:

- High frame rate (max. 40 kHz) → energy resolution on each impinging photon
- Low frame rate (min. 1 kHz) → integration over several photons/pixels
(each pixel dynamics is important !)

Next version:

Higher dynamics (actual dynamics : 15 ke)
+ will integrate a 12 bits ADC (IPHC + LPSC + APC development)

- 256 x 512 pixels
- Pixel pitch: 20 μm
- Total area: 10.5 x 6.2 mm^2
- Rolling or global shutter operation
- Analog readout with programmable MUX (32/16/8/4)

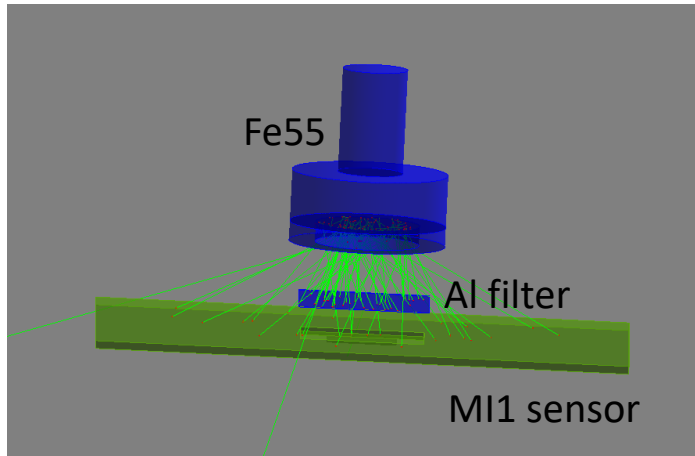
Signal resolution

-
Spectroscopy

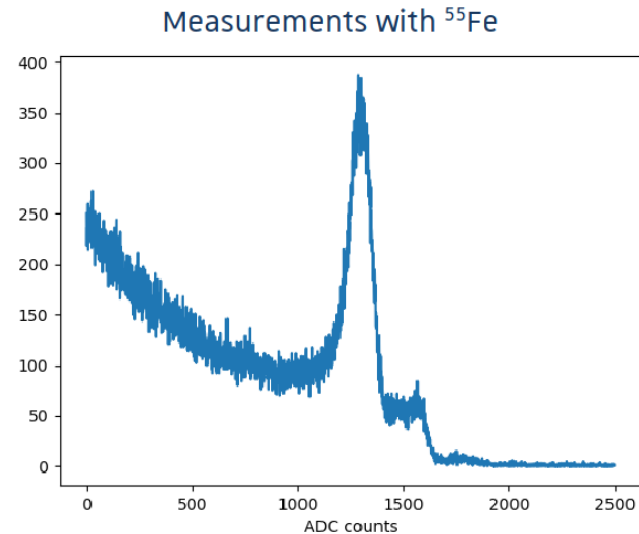
Signal dynamics

-
Particle counting

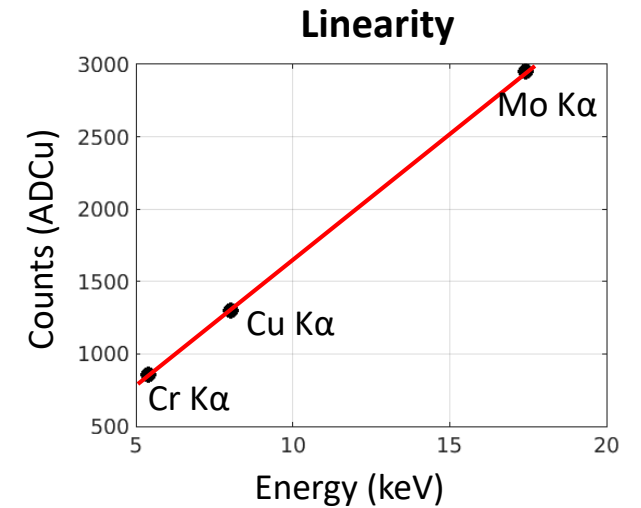
Characterisation



Characterisation setup with
Fe55 sealed source



Energy resolution ~ 180 eV @Mn(K α)
(room temperature)

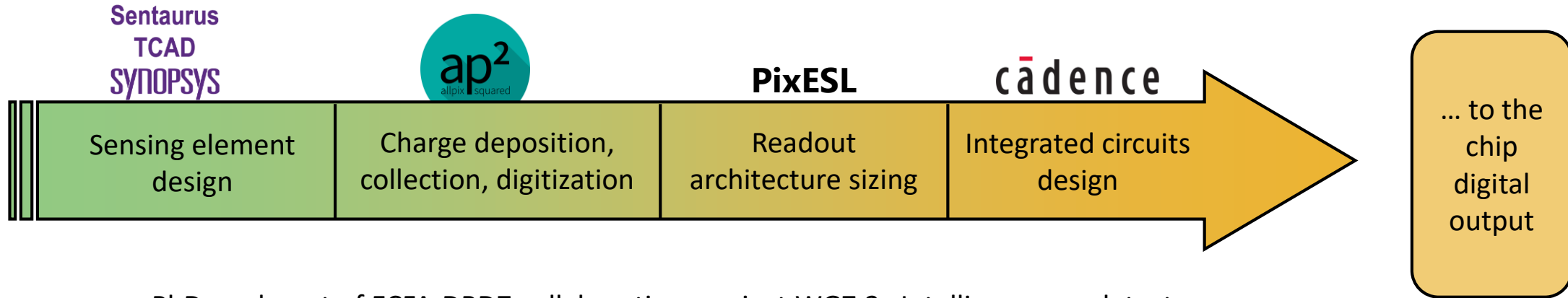


Measurements with X-ray generator

- Measurements performed **in air** (FSI)
- Measurements with soft X-ray (< 2 keV) **in vacuum**, soon @SOLEIL (BSI !)

Developing a physics-electronics integrated simulation based on MI-1

Exhaustive model building for the development of the new generation of CMOS pixel sensors



PhD work part of ECFA-DRD7 collaboration, project WG7.2c Intelligence on-detector
“Virtual electronic system prototyping” (CERN)

Why do we need such a framework?

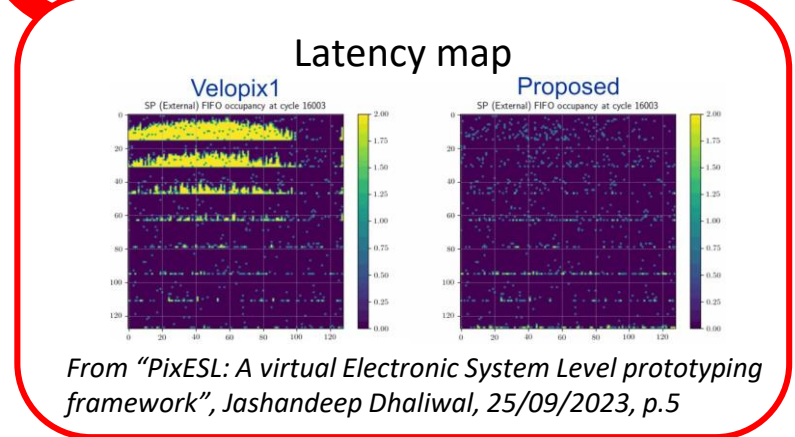
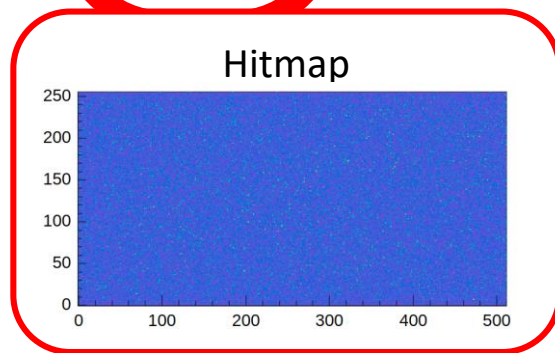
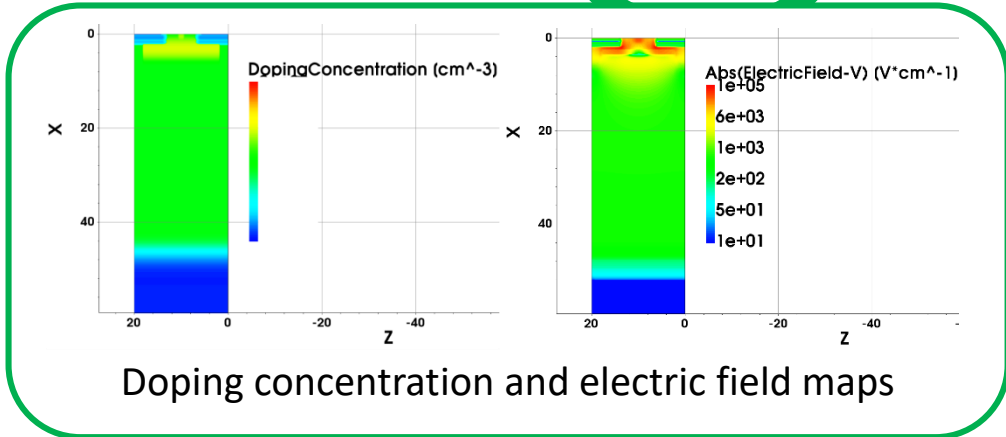
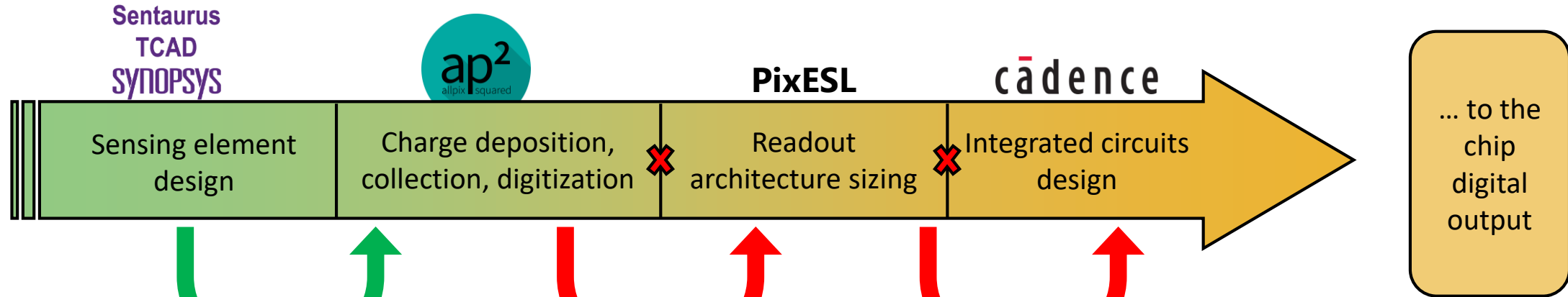
Detector with enhanced performances (always more “aggressive”)

→ Requires accurate simulation on the following aspects:

Charge collection, signal digitization, readout architecture, data flow

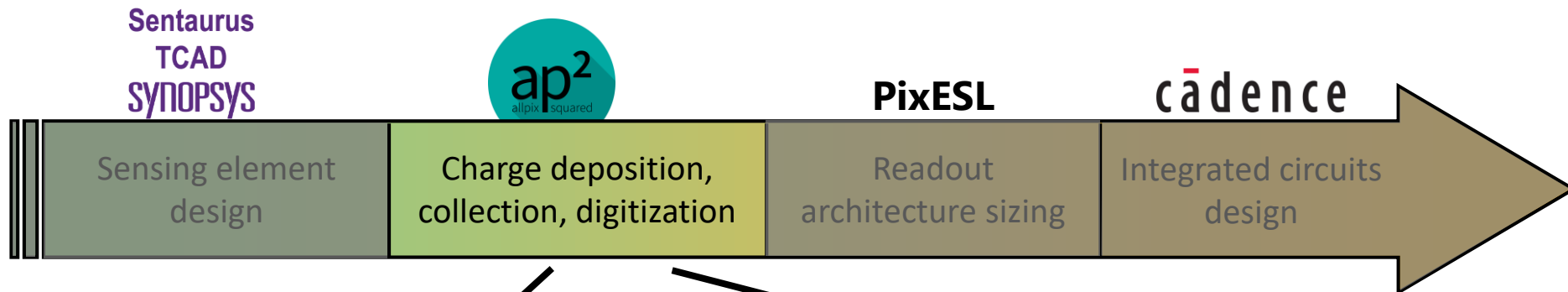
→ **A fluid workflow is mandatory**

Developing a physics-electronics integrated simulation based on MI-1

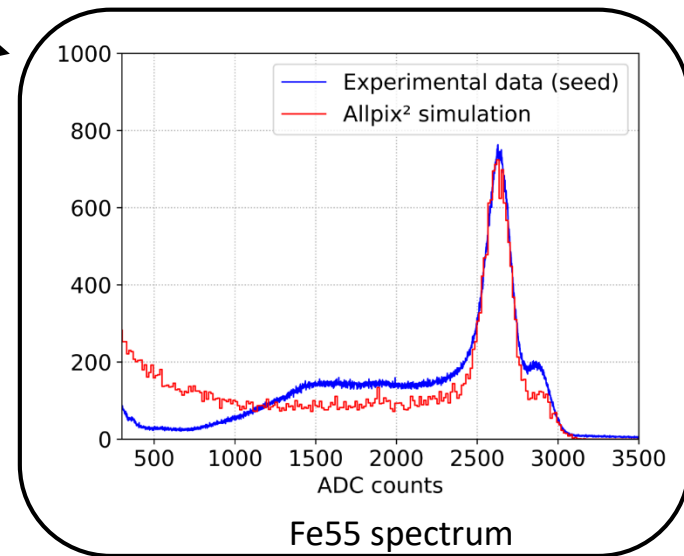
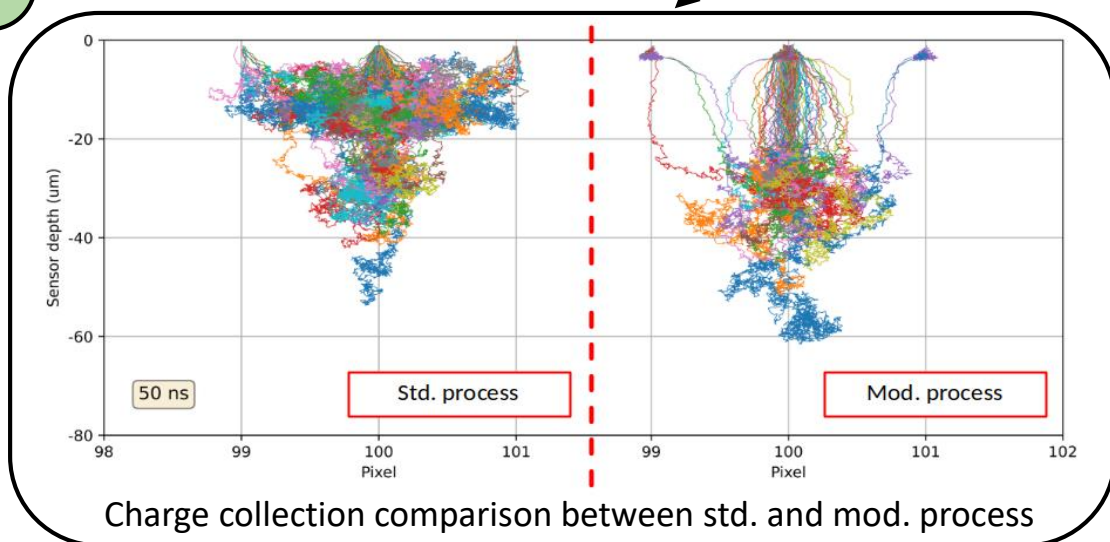


Developing a physics-electronics integrated simulation based on MI-1

From the particle interaction with the sensor...



... to the chip digital output



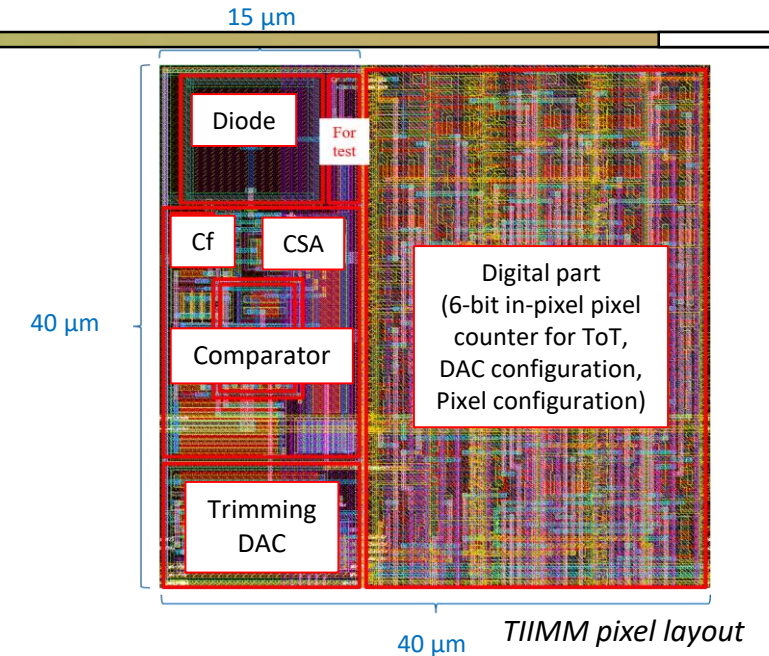
Technology transfer: “TIIMM” sensor

- TIIMM: Tracking and Ions Identifications with Minimal Material budget
- European funding: H2020-INFRAIA / STRONG-2020
- **Designed for position and energy measurement**

Maximum linear range of ToT:

- TIIMM0 : 110ke-
- TIIMM1 : 250ke-
- TIIMM1B : up to 700 ke- (current maxi. of MI-1: 15 ke-)

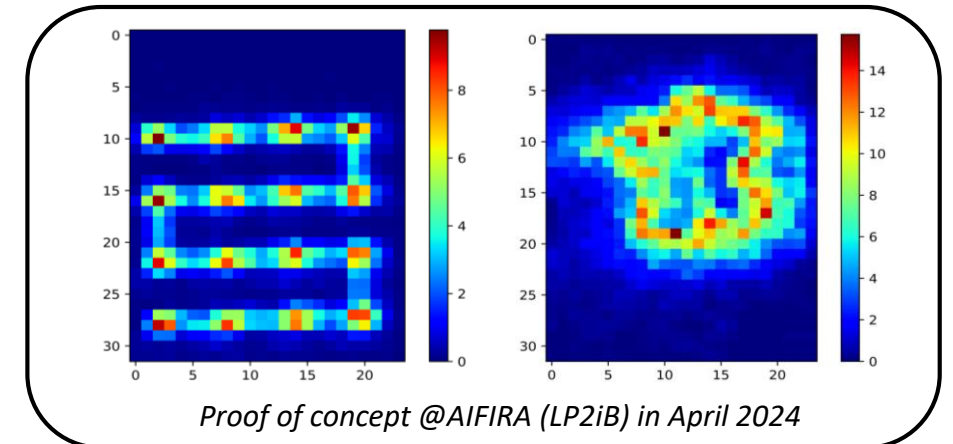
Digitizing already integrated (6 bits ToT) => useful for signal dynamics



Improvements on MI-1

**Pooling of
developments**

Improvements on TIIMM



Conclusion

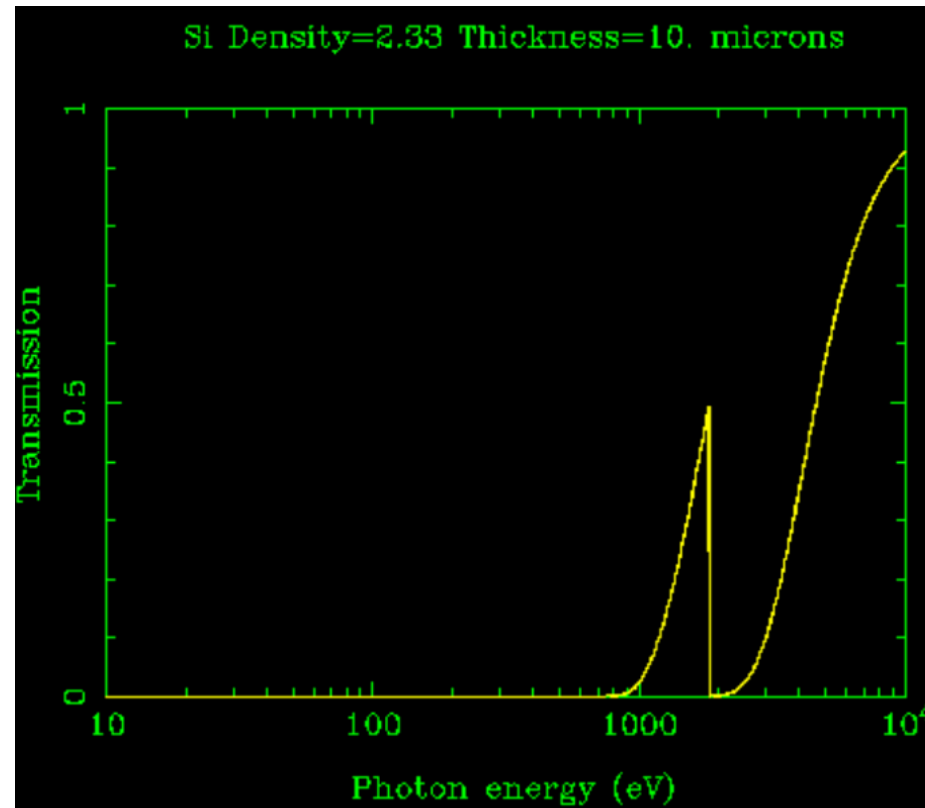
R&D to develop MAPS to fit an application (HEP experiments or spin-off applications)

Processes mastered to optimize low energy X-ray detection

MI1 used as reference for the development of an exhaustive simulation chain

High versatility on the sensors characteristics - Transfer of technology

**Thank you
for your attention !**



Transmission of 10 μm silicon (for the FSI)